10/537119

## JC17 Rec'd PCI/PTO 0.3 JUN 2005

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Susumu NODA et al.

Application No.: New U.S. National Stage of

PCT/JP03/015635

Filed: June 3, 2005 Docket No.: 123456

For: TWO-DIMENSIONAL PHOTONIC CRYSTAL SLAB HAVING THREE-DIMENSIONAL

LOCAL STRUCTURE

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of the non-English language reference 6-7 are discussed in the present specification.
- 3. The references 1-5 were cited in an International Search Report. An English language version of the International Search Report is attached for the Examiner's information.
- 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 5. English language Abstracts of the non-English language references 4-7 are attached hereto.

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6. A computer-generated English language translation of the following Japanese Patent Publication has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 4-7.

7. Reference 3 corresponds with Reference 7.

Respectfully submitted,

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JAO:EDM/mps

Date: June 3, 2005

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE
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Sheet <u>1</u> of <u>1</u>

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE ATION DISCLOSURE STATEMENT		ATTY DOCKET NO. 123456		1	APPLICATION NO. New U.S. National Stage of PCT/JP03/015635 10/537119		
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		U.S	. PAT	ENT DOC	UMENTS				
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	2	WO 02/14913 A1	2/21	/2002	WIPO				
	3	EP 1 136 853 A1	9/26	5/2001	EUROPE	·			
	4	JP A 06-82642 w/ abst & transl	3/25	5/1994	JAPAN				
	5	JP A 06-06490 w/ abst & transl	3/11	/1994	JAPAN	· ·			
	6	JP A 2003-279764 w/ abst & transl	10/2	2/2003	JAPAN			1	
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		OTHER DOCUMENTS (Inc	cluding	g Author,	Title, Date, Pertinent Pag	es, etc.)			
	8	IWAMOTO et al., "Functional Photonic Crystal Devices Using Micro-Electromechanical Systems," 2002 Nen Shuki Dai 63 Kai Extended Abstracts; <i>The Japan Society Of Applied Physics</i> , 26p-YA-8 MEMS o Riyo Shita Kinosei Photonic Kessho Shoshi, Hakko, Dai 3 Bunsatsu, pp. 922 {September 24, 2002}							
	9	TANAKA et al., "Improvement in Q Factor of Point Defect Cavity in SOI Based 2D Photonic Crystal Slab," 2003 Nen Shuki Dai 64 Kai Extended Abstracts; <i>The Japan Society of Applied Physics</i> , 1a-ZM-10, 2-Jigen Photonic Kessho Slab-Ten Kekkan Kyoshinki heno 3-Jigen Kako no Koka-Rironkaiseki, Hakko, Dai 3 Bunsatsu, pp. 942 {August 30, 2003}							
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EXAMINER						DATE CONSIDERED			
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